

**Notice of References Cited**

Application/Control No.

09/985,755

Applicant(s)/Patent Under  
Reexamination  
KUDO ET AL.

Examiner

Drew E Becker

Art Unit

1761

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,004,611 A	12-1999	Gotoh et al.	426/612
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	K	US-			
	L	US-			
	M	US-			

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	N	EP 0525915A1	02-1993	Europe	Yasukawa et al	
	O	WO 99/59424	11-1999	PCT	Mori et al	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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